

<b>Notice of References Cited</b>	Application/Control No. 10/780,789	Applicant(s)/Patent Under Reexamination DU ET AL.	
	Examiner Henry N. Tran	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,512,336	01-2003	De Zwart et al.	315/169.3
*	C	US-6,992,645	01-2006	Kim et al.	345/66
*	D	US-6,677,714	01-2004	Du et al.	315/169.4
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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